BC846BDW1, BC847BDW1, BC848CDW1

Dual General Purpose Transistors

NPN Duals

These transistors are designed for general purpose amplifier applications. They are housed in the SOT−363/SC−88 which is designed for low power surface mount applications.

Features

- S and NSV Prefixes for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC−Q101 Qualified and PPAP Capable
- These Devices are Pb−Free, Halogen Free/BFR Free and are RoHS Compliant*

MAXIMUM RATINGS

Rating	Symbol	BC846	BC847	BC848	Unit
Collector−Emitter Voltage	V_{CEO}	65	45	30	V
Collector−Base Voltage	V_{CBO}	80	50	30	V
Emitter−Base Voltage	V_{EBO}	6.0	6.0	5.0	V
Collector Current − Continuous	I_C	100	100	100	mAdc

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation Per Device FR−5 Board (Note 1) T_A = 25°C Derate Above 25°C	P_D	 380 250 3.0	 mW mW/°C mW/°C
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	328	°C/W
Junction and Storage Temperature Range	T_J, T_{stg}	−55 to +150	°C

1. FR−5 = 1.0 x 0.75 x 0.062 in

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor®

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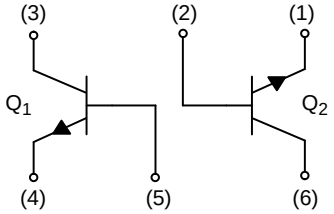
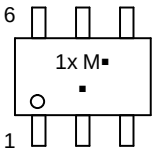
SOT−363
CASE 419B
STYLE 1



MARKING DIAGRAM



1x = Specific Device Code
x = B, F, G, L
M = Date Code
▪ = Pb−Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector−Emitter Breakdown Voltage (I_C = 10 mA)	$V_{(BR)CEO}$				V
BC846		65	–	–	
BC847		45	–	–	
BC848		30	–	–	
Collector−Emitter Breakdown Voltage (I_C = 10 μA, V_{EB} = 0)	$V_{(BR)CES}$				V
BC846		80	–	–	
BC847		50	–	–	
BC848		30	–	–	
Collector−Base Breakdown Voltage (I_C = 10 μA)	$V_{(BR)CBO}$				V
BC846		80	–	–	
BC847		50	–	–	
BC848		30	–	–	
Emitter−Base Breakdown Voltage (I_E = 1.0 μA)	$V_{(BR)EBO}$				V
BC846		6.0	–	–	
BC847		6.0	–	–	
BC848		5.0	–	–	
Collector Cutoff Current	I_{CBO}				
(V_{CB} = 30 V)		–	–	15	nA
(V_{CB} = 30 V, T_A = 150°C)		–	–	5.0	μA
ON CHARACTERISTICS					
DC Current Gain (I_C = 10 μA, V_{CE} = 5.0 V)	h_{FE}				–
BC846B, BC847B		–	150	–	
BC847C, BC848C		–	270	–	
(I_C = 2.0 mA, V_{CE} = 5.0 V)					
BC846B, BC847B		200	290	450	
BC847C, BC848C		420	520	800	
Collector−Emitter Saturation Voltage	$V_{CE(sat)}$				V
(I_C = 10 mA, I_B = 0.5 mA)		–	–	0.25	
(I_C = 100 mA, I_B = 5.0 mA)		–	–	0.6	
Base−Emitter Saturation Voltage	$V_{BE(sat)}$				V
(I_C = 10 mA, I_B = 0.5 mA)		–	0.7	–	
(I_C = 100 mA, I_B = 5.0 mA)		–	0.9	–	
Base−Emitter Voltage	$V_{BE(on)}$				mV
(I_C = 2.0 mA, V_{CE} = 5.0 V)		580	660	700	
(I_C = 10 mA, V_{CE} = 5.0 V)		–	–	770	
SMALL−SIGNAL CHARACTERISTICS					
Current−Gain − Bandwidth Product (I_C = 10 mA, V_{CE} = 5.0 Vdc, f = 100 MHz)	f_T	100	–	–	MHz
Output Capacitance (V_{CB} = 10 V, f = 1.0 MHz)	C_{obo}	–	–	4.5	pF
Noise Figure (I_C = 0.2 mA, V_{CE} = 5.0 Vdc, R_S = 2.0 kΩ,f = 1.0 kHz, BW = 200 Hz)	NF	–	–	10	dB

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS − BC846BDW1

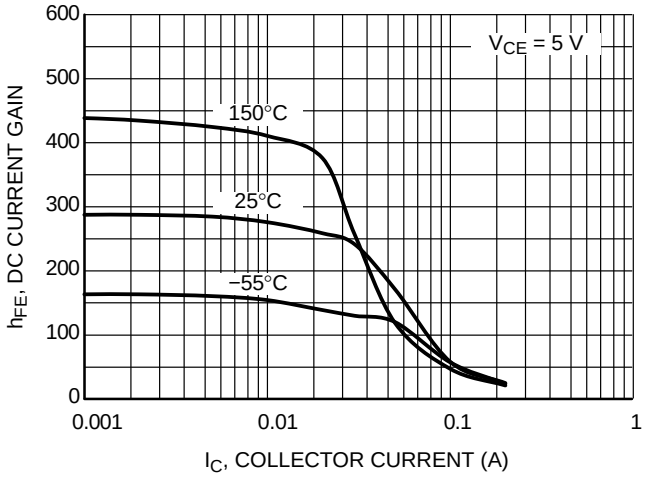


Figure 1. DC Current Gain at V_{CE} = 5 V

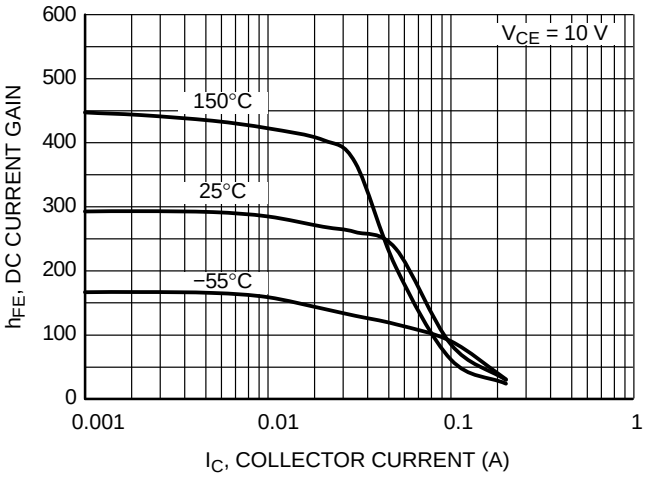


Figure 2. DC Current Gain at V_{CE} = 10 V

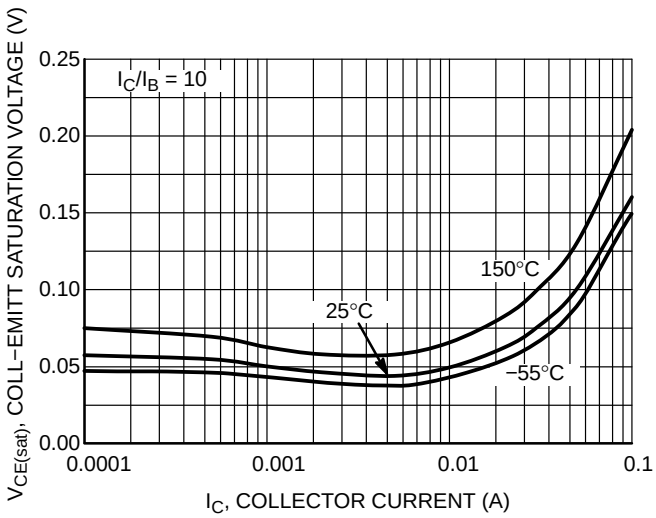


Figure 3. $V_{CE(sat)}$ at I_C/I_B = 10

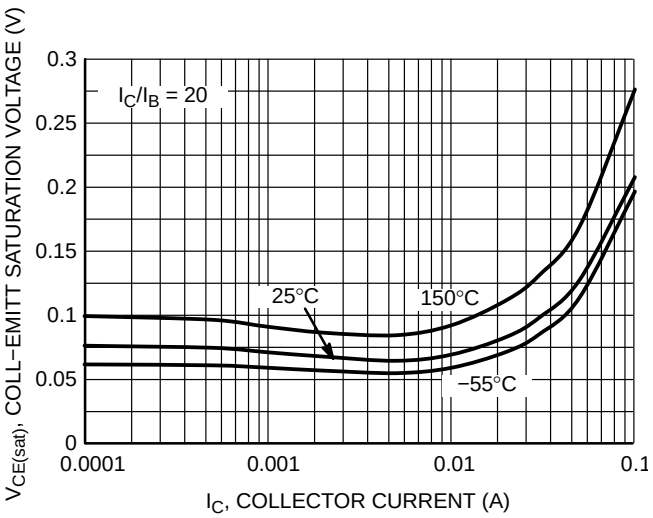


Figure 4. $V_{CE(sat)}$ at I_C/I_B = 20

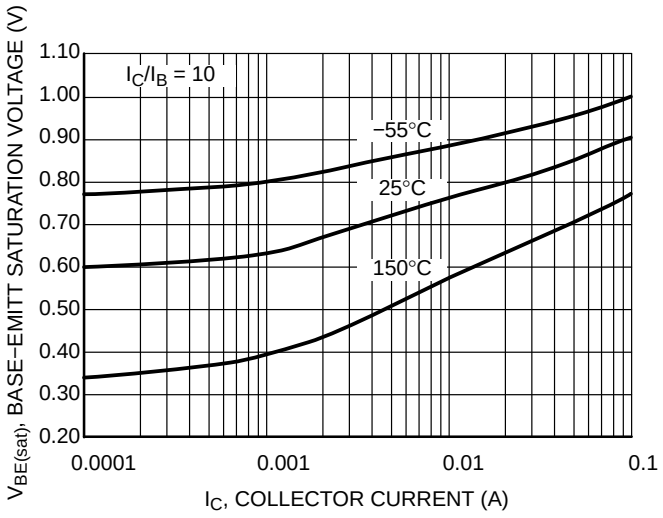


Figure 5. $V_{BE(sat)}$ at I_C/I_B = 10

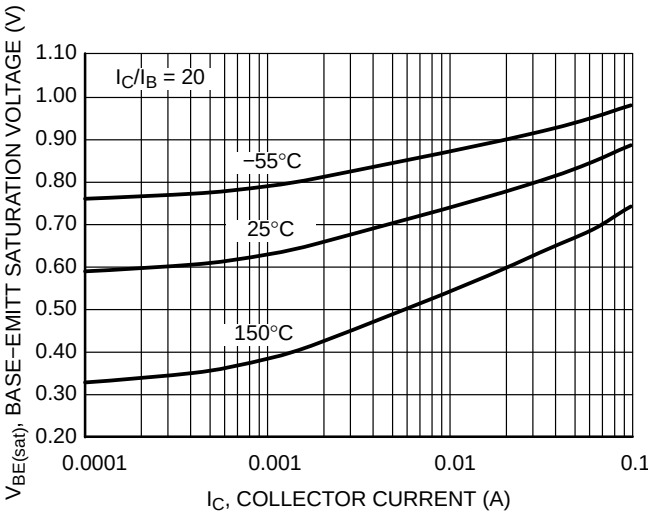


Figure 6. $V_{BE(sat)}$ at I_C/I_B = 20

TYPICAL CHARACTERISTICS − BC846BDW1

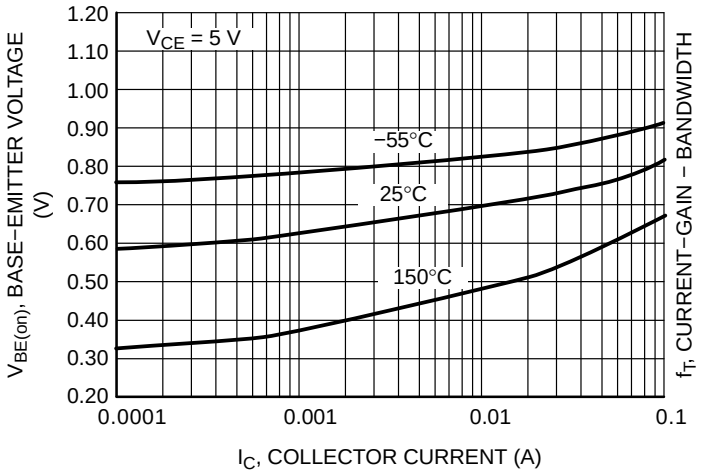


Figure 7. $V_{BE(on)}$ at V_{CE} = 5 V

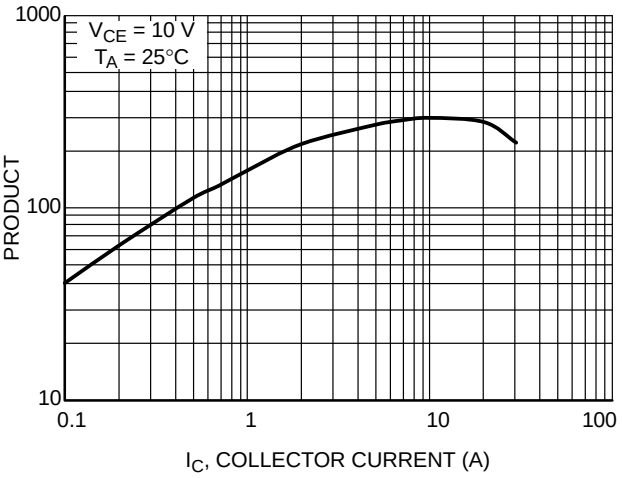


Figure 8. Current − Gain − Bandwidth Product

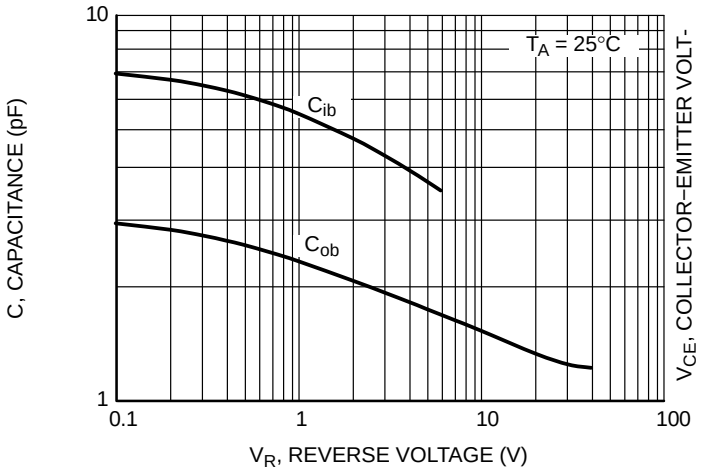


Figure 9. Capacitances

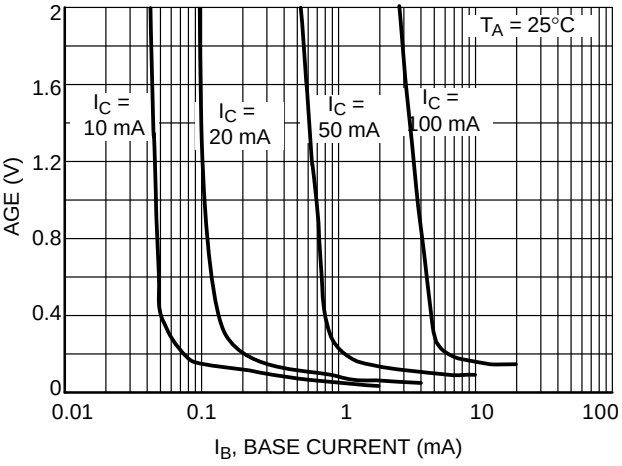


Figure 10. Collector Saturation Region

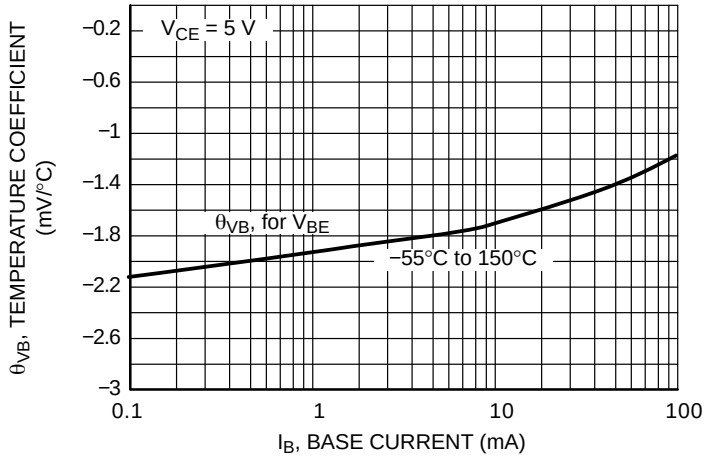


Figure 11. Base−Emitter Temperature Coefficient

TYPICAL CHARACTERISTICS − BC847BDW1

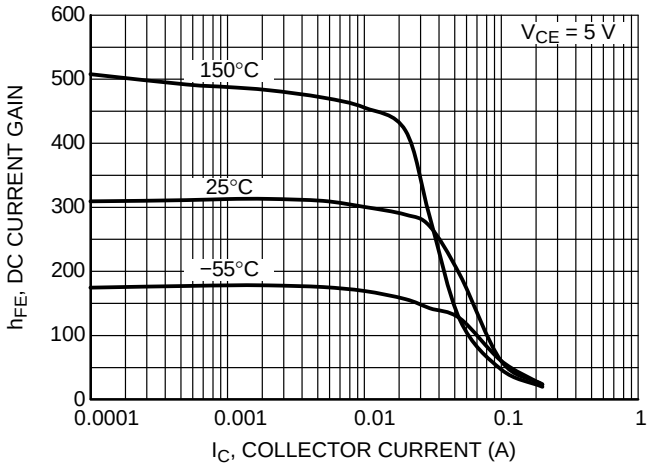


Figure 12. DC Current Gain at V_{CE} = 5 V

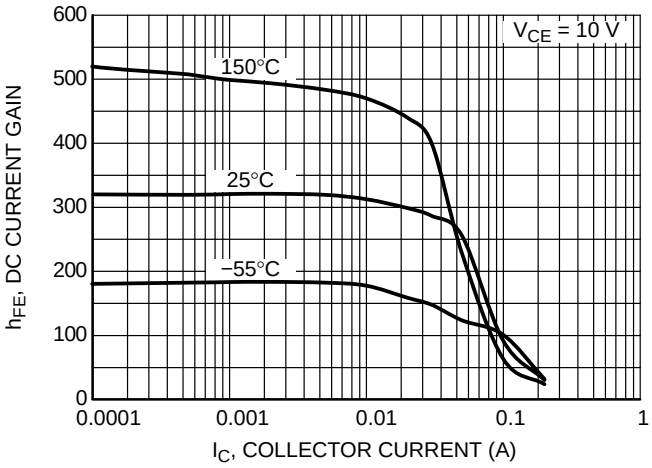


Figure 13. DC Current Gain at V_{CE} = 10 V

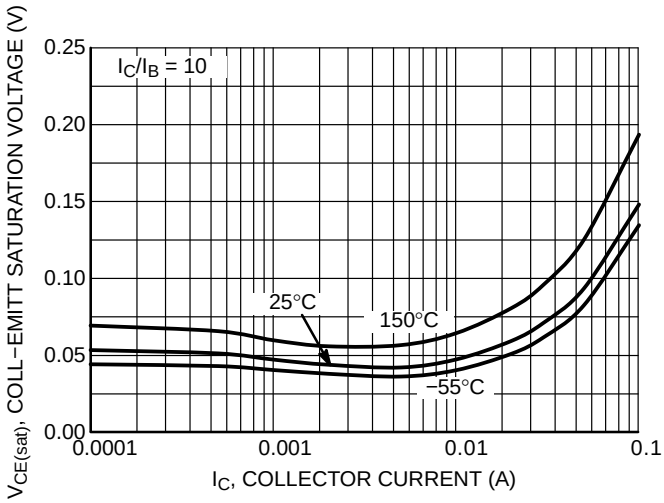


Figure 14. V_{CE} at I_C/I_B = 10

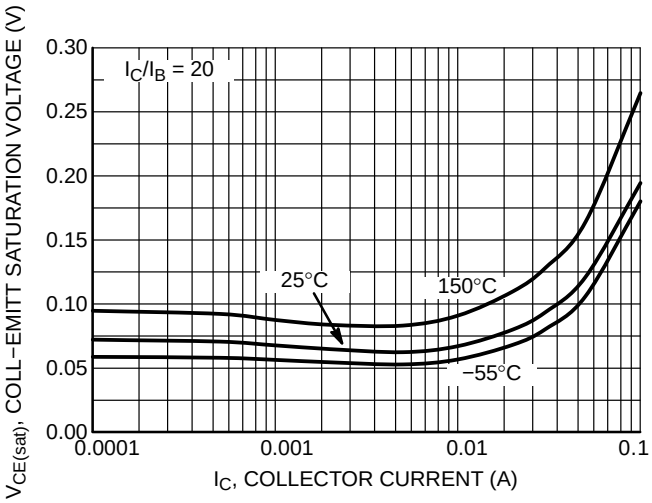


Figure 15. V_{CE} at I_C/I_B = 20

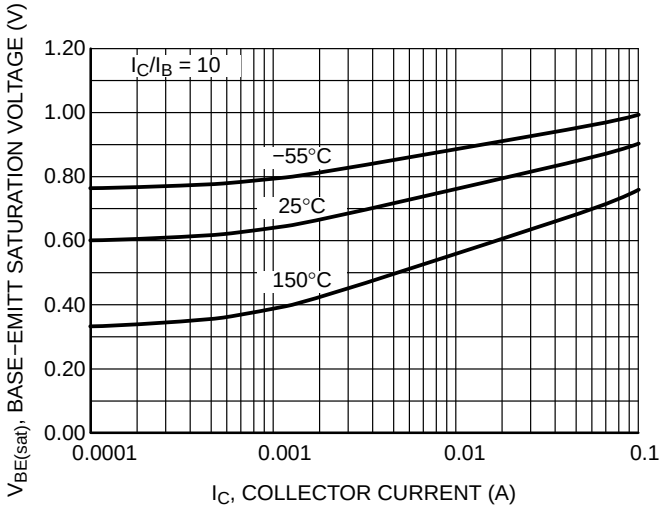


Figure 16. $V_{BE(sat)}$ at I_C/I_B = 10

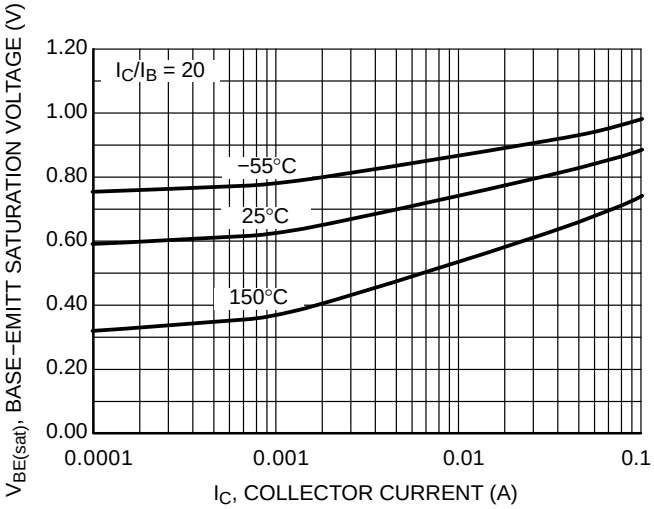


Figure 17. $V_{BE(sat)}$ at I_C/I_B = 20

TYPICAL CHARACTERISTICS − BC847BDW1

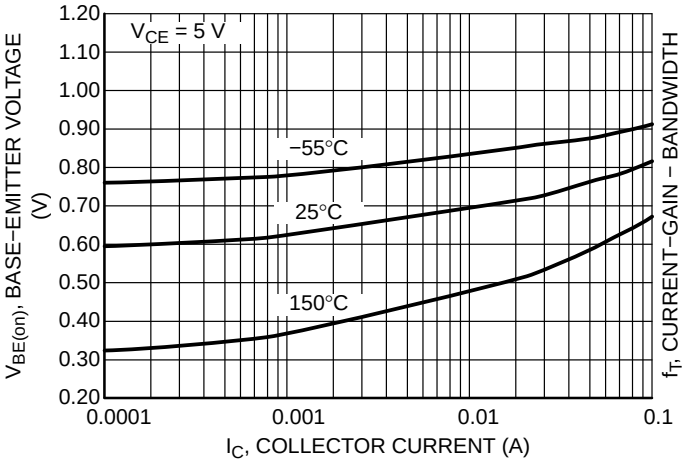


Figure 18. $V_{BE(on)}$ at V_{CE} = 5 V

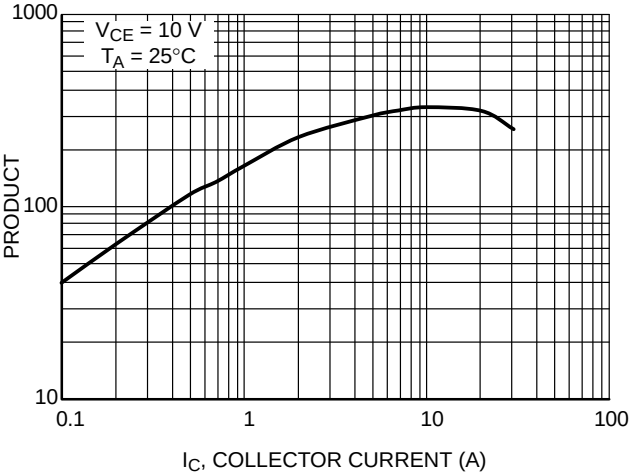


Figure 19. Current − Gain − Bandwidth Product

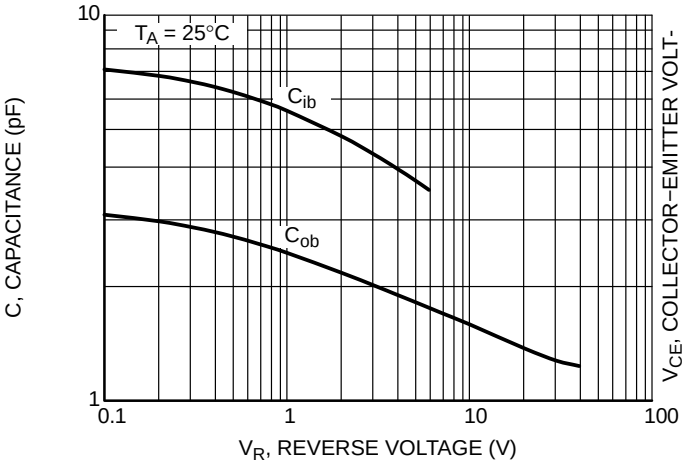


Figure 20. Capacitances

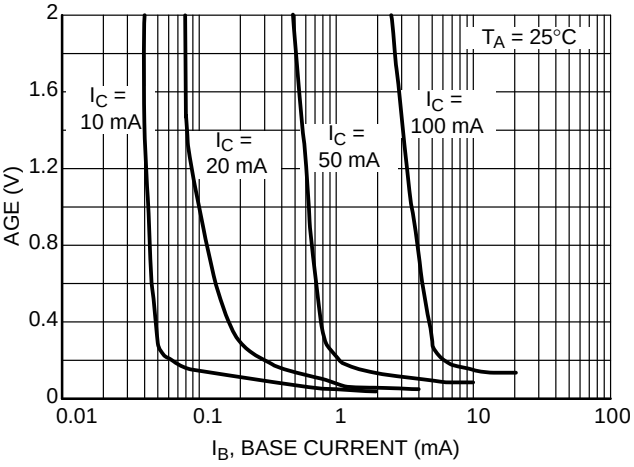


Figure 21. Collector Saturation Region

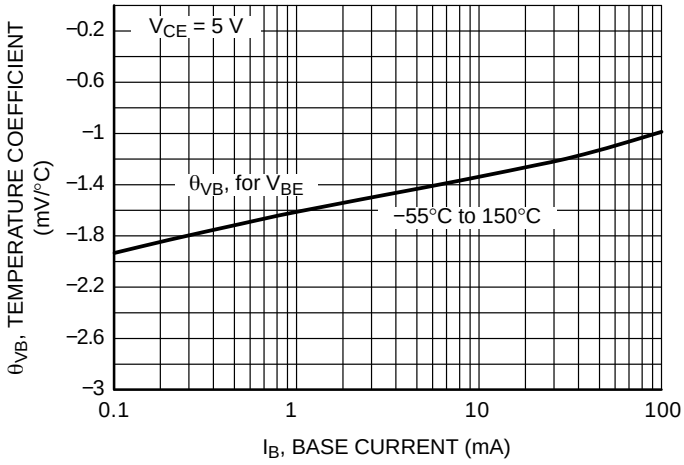


Figure 22. Base−Emitter Temperature Coefficient

TYPICAL CHARACTERISTICS − BC848CDW1

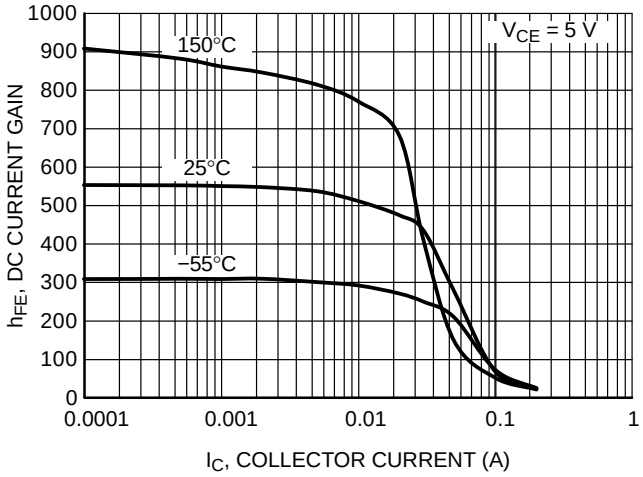


Figure 23. DC Current Gain at V_{CE} = 5 V

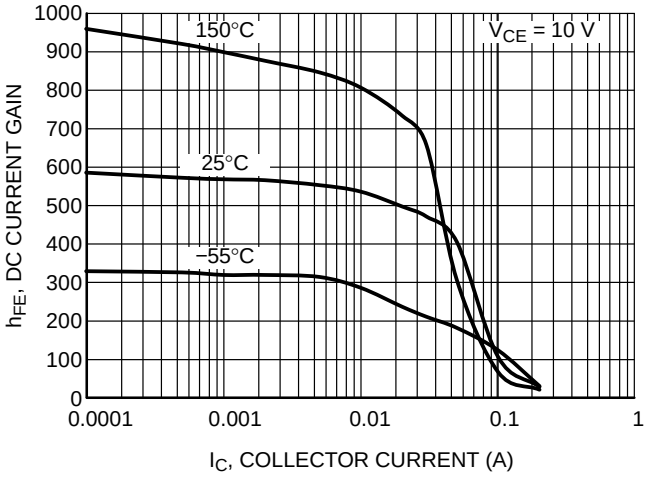


Figure 24. DC Current Gain at V_{CE} = 10 V

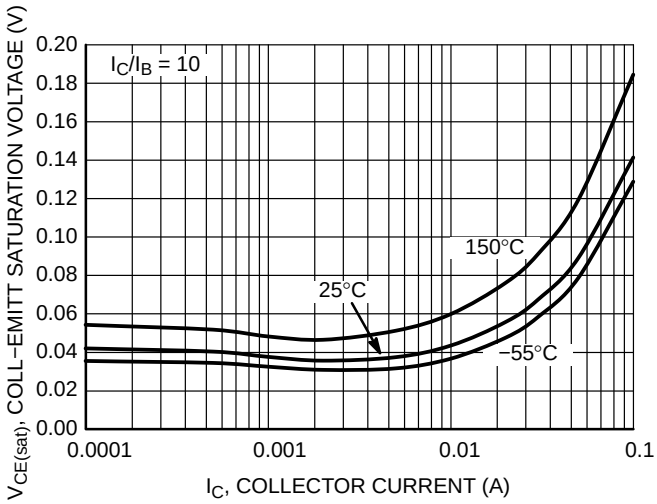


Figure 25. V_{CE} at I_C/I_B = 10

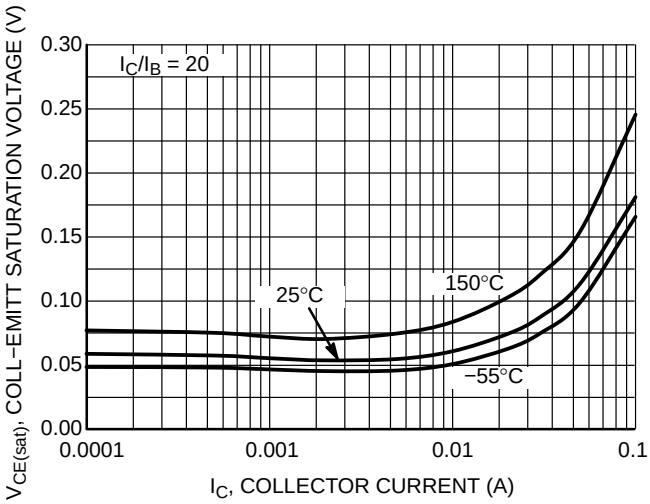


Figure 26. V_{CE} at I_C/I_B = 20

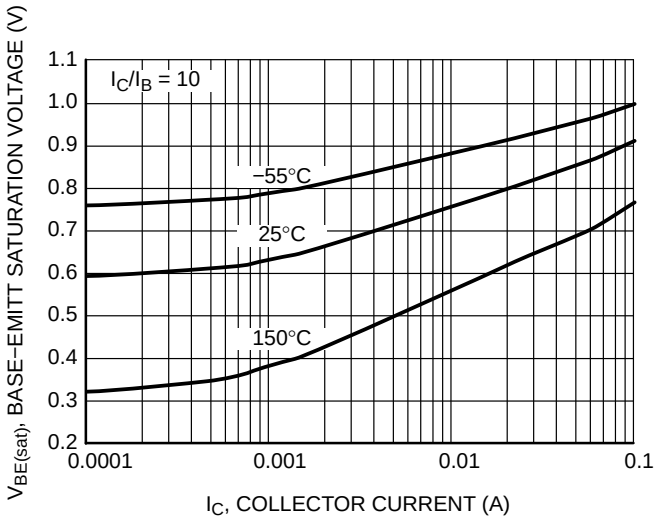


Figure 27. $V_{BE(sat)}$ at I_C/I_B = 10

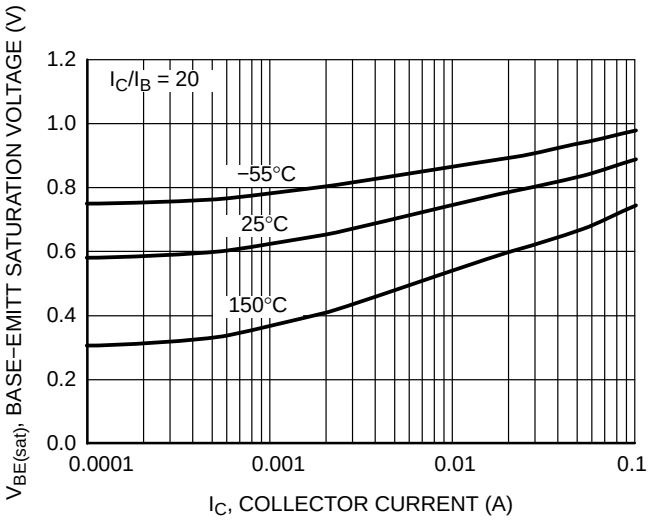


Figure 28. $V_{BE(sat)}$ at I_C/I_B = 20

TYPICAL CHARACTERISTICS − BC848CDW1

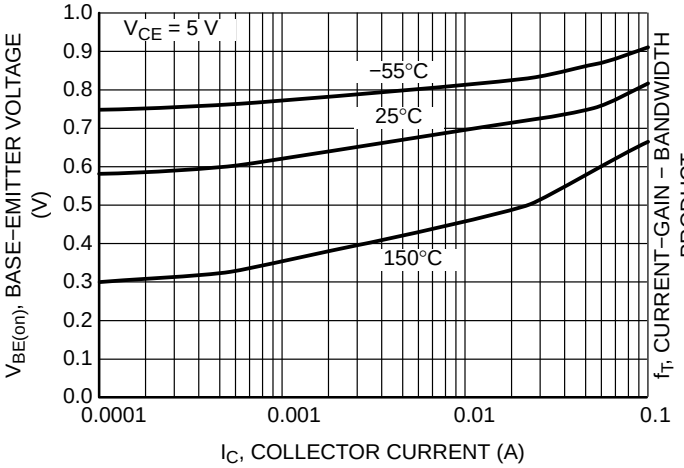


Figure 29. $V_{BE(on)}$ at V_{CE} = 5 V

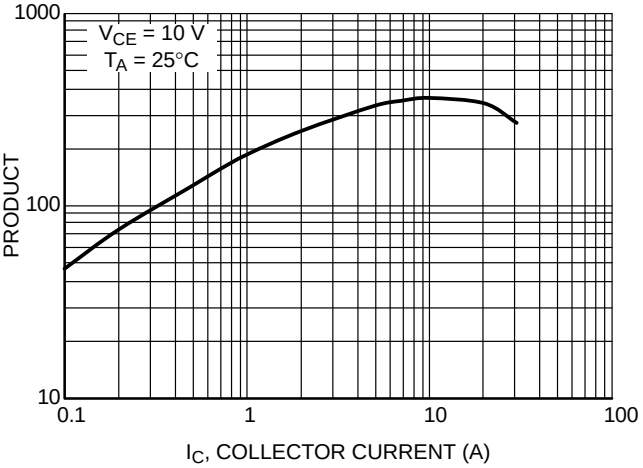


Figure 30. Current − Gain − Bandwidth Product

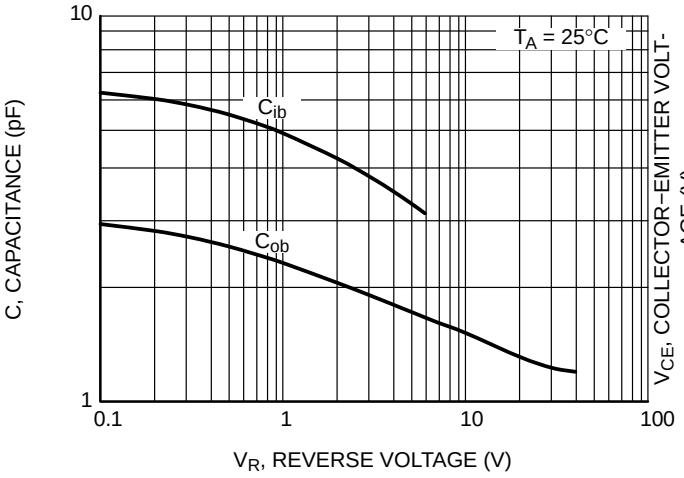


Figure 31. Capacitances

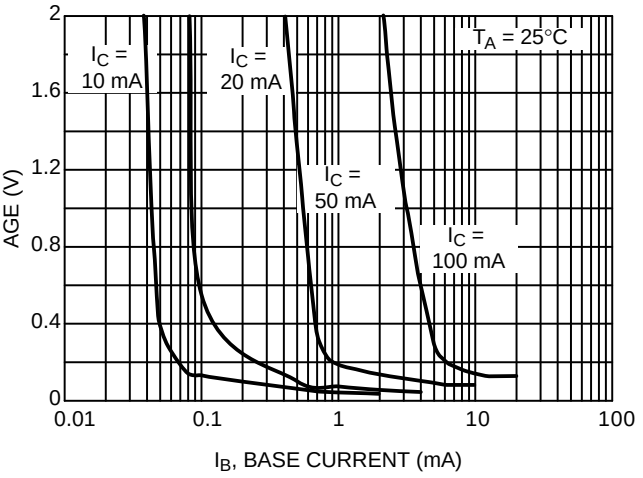


Figure 32. Collector Saturation Region

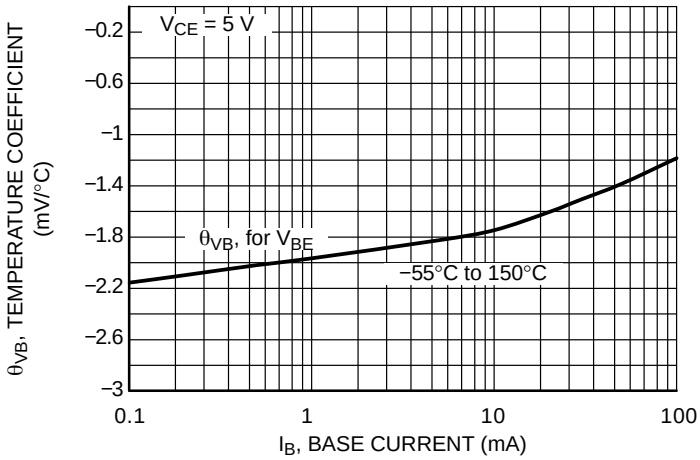


Figure 33. Base−Emitter Temperature Coefficient

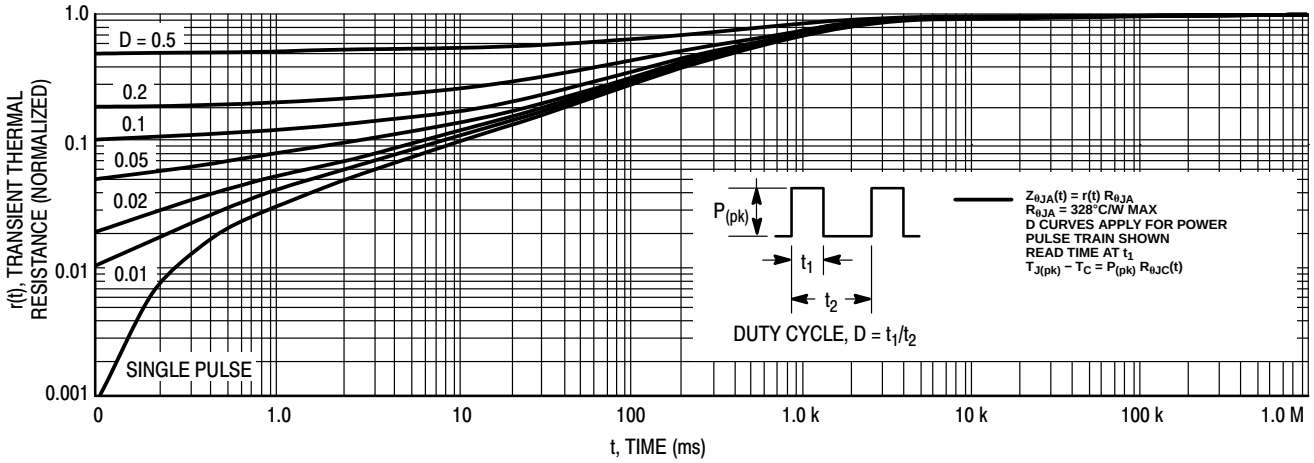


Figure 34. Thermal Response

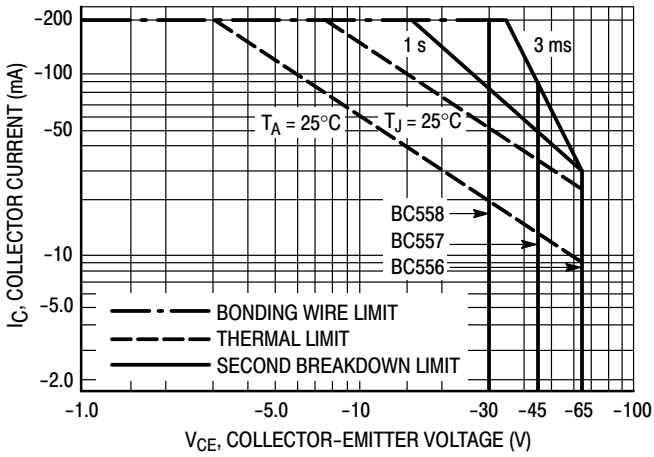


Figure 35. Active Region Safe Operating Area

The safe operating area curves indicate I_C−V_{CE} limits of the transistor that must be observed for reliable operation. Collector load lines for specific circuits must fall below the limits indicated by the applicable curve.

The data of Figure 35 is based upon $T_{J(pk)}$ = 150°C; T_C or T_A is variable depending upon conditions. Pulse curves are valid for duty cycles to 10% provided $T_{J(pk)} \leq$ 150°C. $T_{J(pk)}$ may be calculated from the data in Figure 34. At high case or ambient temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by the secondary breakdown.

ORDERING INFORMATION

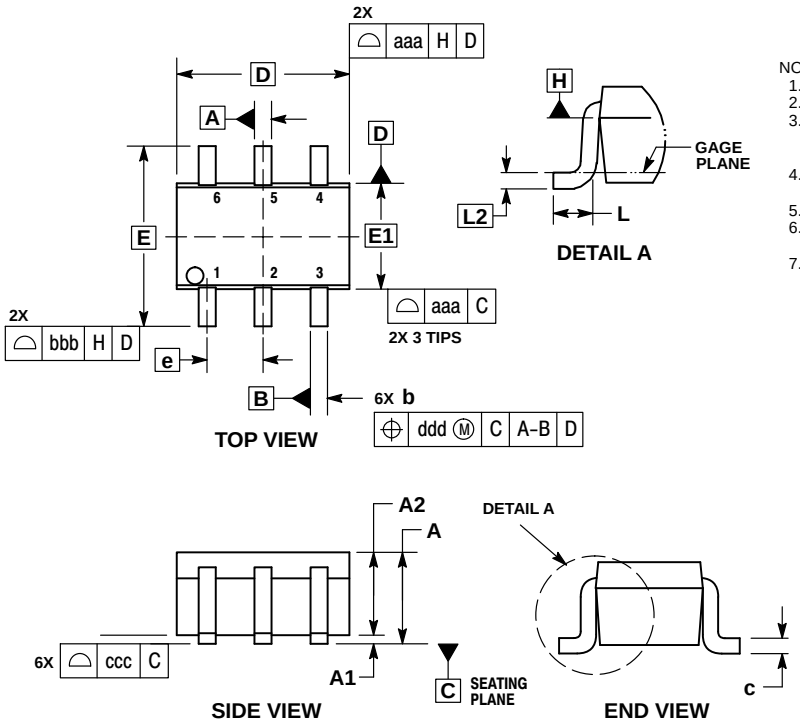
Device	Markings	Package	Shipping†
BC846BDW1T1G	1B	SOT−363 (Pb−Free)	3,000 / Tape & Reel
SBC846BDW1T1G*	1B	SOT−363 (Pb−Free)	3,000 / Tape & Reel
BC847BDW1T1G	1F	SOT−363 (Pb−Free)	3,000 / Tape & Reel
SBC847BDW1T1G*	1F	SOT−363 (Pb−Free)	3,000 / Tape & Reel
BC847BDW1T3G	1F	SOT−363 (Pb−Free)	10,000 / Tape & Reel
SBC847BDW1T3G*	1F	SOT−363 (Pb−Free)	10,000 / Tape & Reel
NSVBC847BDW1T2G*	1F	SOT−363 (Pb−Free)	10,000 / Tape & Reel
BC847CDW1T1G	1G	SOT−363 (Pb−Free)	3,000 / Tape & Reel
SBC847CDW1T1G*	1G	SOT−363 (Pb−Free)	3,000 / Tape & Reel
BC848CDW1T1G	1L	SOT−363 (Pb−Free)	3,000 / Tape & Reel
NSVBC848CDW1T1G*	1L	SOT−363 (Pb−Free)	3,000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

*S and NSV Prefixes for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC−Q101 Qualified and PPAP Capable.

PACKAGE DIMENSIONS

SC−88/SC70−6/SOT−363
CASE 419B−02
ISSUE Y

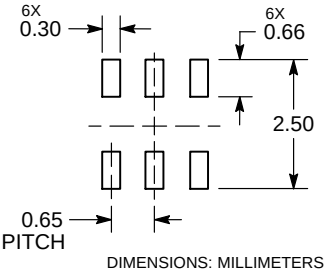


NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.20 PER END.
4. DIMENSIONS D AND E1 AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY AND DATUM H.
5. DATUMS A AND B ARE DETERMINED AT DATUM H.
6. DIMENSIONS b AND c APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.08 AND 0.15 FROM THE TIP.
7. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 TOTAL IN EXCESS OF DIMENSION b AT MAXIMUM MATERIAL CONDITION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE FOOT.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
A	−−−	−−−	1.10	−−−	−−−	0.043
A1	0.00	−−−	0.10	0.000	−−−	0.004
A2	0.70	0.90	1.00	0.027	0.035	0.039
b	0.15	0.20	0.25	0.006	0.008	0.010
C	0.08	0.15	0.22	0.003	0.006	0.009
D	1.80	2.00	2.20	0.070	0.078	0.086
E	2.00	2.10	2.20	0.078	0.082	0.086
E1	1.15	1.25	1.35	0.045	0.049	0.053
e	0.65 BSC			0.026 BSC		
L	0.26	0.36	0.46	0.010	0.014	0.018
L2	0.15 BSC			0.006 BSC		
aaa	0.15			0.006		
bbb	0.30			0.012		
ccc	0.10			0.004		
ddd	0.10			0.004		

STYLE 1:
PIN 1. EMITTER 2
2. BASE 2
3. COLLECTOR 1
4. EMITTER 1
5. BASE 1
6. COLLECTOR 2

RECOMMENDED SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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